

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

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Applicant:	Yoram Uziel et al.)			
Application No.	09/721,167)		#1	14B
Filed:	November 22, 2000)	Group Art Unit: 1763	2/	20/0
For:	IN SITU MODULE FOR PARTICLE REMOVAL FROM SOLID-STATE SURFACES)		ı	MW
Examiner:	Parviz Hassanzadeh)	Attorney Docket No. STC-3	3 <u>8090</u>	-
	<u>AMENDMEN</u>	<u>IT</u>	TC 1700 M	FEB 19	RECEIVED
Commissioner for Patents Washington, D. C. 20231			MAIL ROC	2003	CEN
Sir:			9		

In response to an Official Action dated September 11, 2002, kindly amend the above-referenced application as follows:

IN THE FIGURES:

Amended Figs. 3, 4 and 5 (now labeled Fig. 5A) are submitted herewith, showing proposed corrections to the drawings. A new Fig. 5B is submitted herewith, as well, as discussed in the remarks below.

IN THE SPECIFICATION:

Kindly amend the following paragraphs of the specification, so that they read as follows. A marked-up version of the amended specification paragraphs is attached hereto.

Please replace the paragraph beginning at page 8, line 20, with the following rewritten paragraph:



-- Fig. 5A is a schematic, sectional view of a cleaning module for removal of particles from a substrate during a manufacturing process, in accordance with a preferred embodiment of the present invention; --